


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510482	<b>Applicant(s)/Patent Under Reexamination</b>  CHIANG ET AL.
	<b>Examiner</b>  SAIRA HAIDER	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
	Updated Search Notes of 12/1/2007	6/2008	SH
	Updated	2/2009	SH

SEARCH NOTES		
Search Notes	Date	Examiner
Updated Search Notes of 12/1/2007	6/2008	SH
Updated	2/2009	SH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--